

10/512082

DT15 Rec'd PCT/PTO 08 NOV 2004

Docket No. 26133US2PCT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Takao SAWADA, et al.

SERIAL NO: New U.S. PCT Application Based on PCT/JP02/06127

GAU:

FILED: Herewith

EXAMINER:

FOR: METHOD FOR REDUCING FLUCTUATION OF CUT-OFF VOLTAGE, CATHODE FOR ELECTRONIC TUBE,
AND METHOD FOR MANUFACTURING CATHODE FOR ELECTRONIC TUBE

INFORMATION DISCLOSURE STATEMENT UNDER 37 CFR 1.97

COMMISSIONER FOR PATENTS
ALEXANDRIA, VIRGINIA 22313

SIR:

Applicant(s) wish to disclose the following information.

REFERENCES

- The applicant(s) wish to make of record the references listed on the attached form PTO-1449. Copies of the listed references are attached, where required, as are either statements of relevancy or any readily available English translations of pertinent portions of any non-English language references.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

RELATED CASES

- Attached is a list of applicant's pending application(s), published application(s) or issued patent(s) which may be related to the present application. In accordance with the waiver of 37 CFR 1.98 dated September 21, 2004, copies of the cited pending applications are not provided. Cited published and/or issued patents, if any, are listed on the attached PTO form 1449.
- A check or credit card payment form is attached in the amount required under 37 CFR §1.17(p).

CERTIFICATION

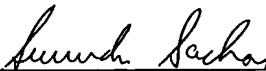
- Each item of information contained in this information disclosure statement was first cited in any communication from a foreign patent office in a counterpart foreign application not more than three months prior to the filing of this statement.
- No item of information contained in this information disclosure statement was cited in a communication from a foreign patent office in a counterpart foreign application or, to the knowledge of the undersigned, having made reasonable inquiry, was known to any individual designated in 37 CFR §1.56(c) more than three months prior to the filing of this statement.

DEPOSIT ACCOUNT

- Please charge any additional fees for the papers being filed herewith and for which no check or credit card payment is enclosed herewith, or credit any overpayment to deposit account number 15-0030. A duplicate copy of this sheet is enclosed.

Respectfully submitted,

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New U.S. PCT Application Based on PCT/JP02/06127
Docket No.: 261333US2PCT

STATEMENT OF RELEVANCY

- 1) References AO-AS have been cited in the International Search Report. Copies of these references are being submitted herewith only when not automatically provided by the International Searching Authority.
- 2) References _____ have been cited in the corresponding _____ Search Report. A copy of these references is being submitted herewith.
- 3) References AT-AV are discussed in the specification. A copy of these references is being submitted here with.
- 4) Reference AW is additional prior art known to Applicant. A copy of this reference is being submitted herewith.

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SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 261333US2PCT		SERIAL NO. New U.S. PCT Application Based on PCT/JP02/06127	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Takao SAWADA, et al.			
				FILING DATE Herewith	GROUP		
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
					YES	NO	
	AO	2000-40461	02/08/00	JP			NO
	AP	58-189940	11/05/83	JP			NO
	AQ	61-4133	01/10/86	JP			NO
	AR	9-190761	07/22/97	JP (equivalent of US 6091189)			NO
	AS	2000-251613	09/14/00	JP			NO
	AT	9-106750	04/22/97	JP (equivalent of US 5118984)			NO
	AU	2758244	03/13/98	JP (equivalent of US 5118984)			NO
	AV	54-83360	07/03/79	JP (equivalent of US 4273683)			NO
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	HAYASHIDA, Y. et al. "An Analysis of Cut-Off Voltage Drift in the Oxide Cathode Life", Electronics Research Laboratory, Matsushita Electronics Corporation, pages 67-72, with English abstract 1995					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							